

# 64M(2Mx32) DDR SDRAM

## HY5DU663222Q-7M

## Revision History

### 1. Revision 0.4 (Dec. 01)

- 1) Separated 'Function description' and 'Timing diagram' parts
  - These are available in Web site ([www.hynix.com](http://www.hynix.com))

## DESCRIPTION

The Hynix HY5DU663222 is a 67,108,864-bit CMOS Double Data Rate(DDR) Synchronous DRAM, ideally suited for the point-to-point applications which requires high bandwidth.

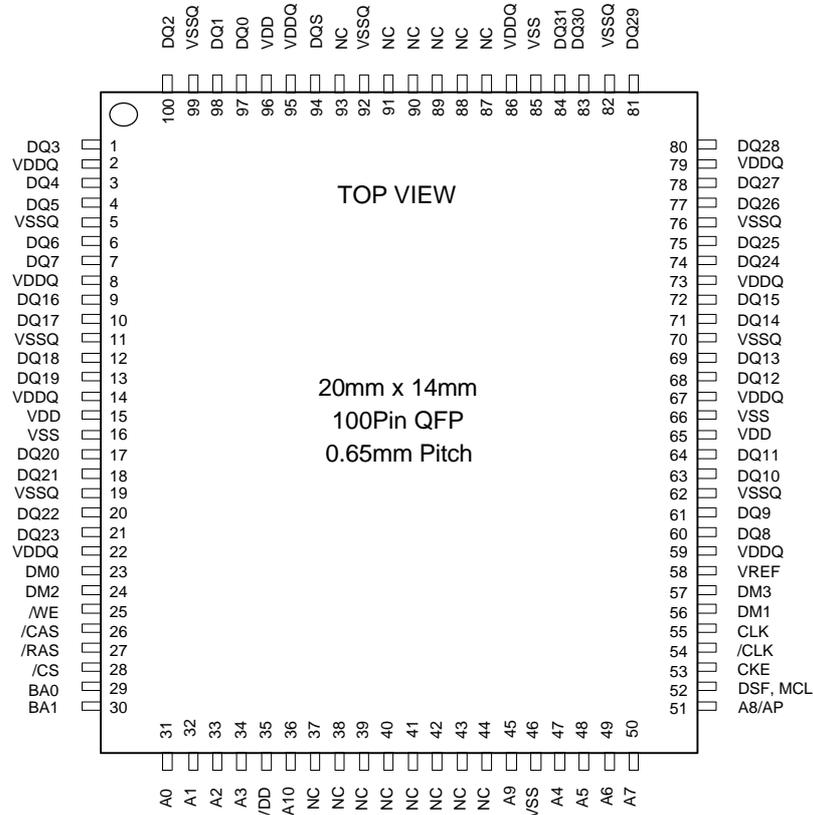
The Hynix 2Mx32 DDR SDRAMs offer fully synchronous operations referenced to both rising and falling edges of the clock. While all addresses and control inputs are latched on the rising edges of the CK (falling edges of the /CK), Data, Data strobes and Write data masks inputs are sampled on both rising and falling edges of it. The data paths are internally pipelined and 2-bit prefetched to achieve very high bandwidth. All input and output voltage levels are compatible with SSTL\_2.

## FEATURES

- VDD, VDDQ = 2.5V ± 5%
- All inputs and outputs are compatible with SSTL\_2 interface
- JEDEC standard 20mm x 14mm 100pin LQFP with 0.65mm pin pitch
- Fully differential clock inputs (CK, /CK) operation
- Double data rate interface
- Source synchronous - data transaction aligned to bidirectional data strobe (DQS)
- Data outputs on DQS edges when read (edged DQ)  
Data inputs on DQS centers when write (centered DQ)
- Data(DQ) and Write masks(DM) latched on the both rising and falling edges of the data strobe
- All addresses and control inputs except Data, Data strobes and Data masks latched on the rising edges of the clock
- Write mask byte controls by DM (DM0 ~ DM3)
- Programmable /CAS Latency 2 and 3 supported
- Programmable Burst Length 2 / 4 / 8 with both sequential and interleave mode
- Internal 4 bank operations with single pulsed /RAS
- Auto refresh and self refresh supported
- 2048 refresh cycles / 16ms
- Full and Half strength driver option controlled by EMRS

## ORDERING INFORMATION

Part No.	Power Supply	Clock Frequency	Max Data Rate	interface	Package
HY5DU663222Q-7M	VDD/VDDQ = 2.5V	143MHz	286Mbps/pin	SSTL_2	20mm x 14mm 100pin LQFP
HY5DU663222Q-75		133MHz	266Mbps/pin		
HY5DU663222Q-8		125MHz	250Mbps/pin		

**PIN CONFIGURATION**

**ROW and COLUMN ADDRESS TABLE**

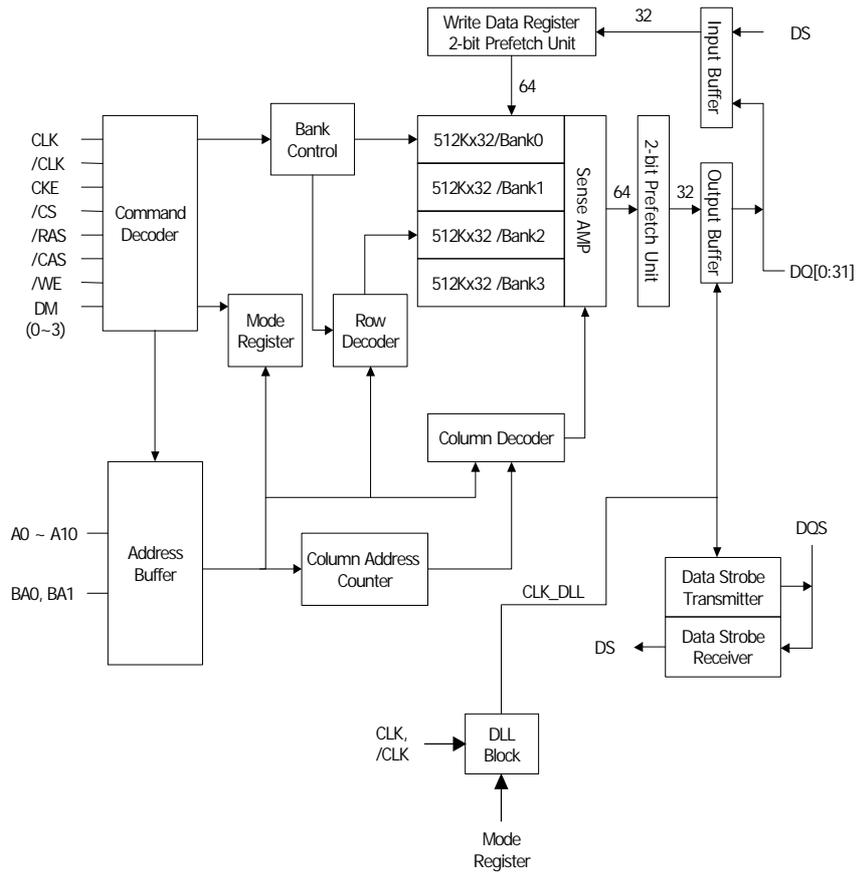
Items	2Mx32
Organization	512K x 32 x 4banks
Row Address	A0 ~ A10
Column Address	A0 ~ A7
Bank Address	BA0, BA1
Auto Precharge Flag	A8
Refresh	2K

**PIN DESCRIPTION**

PIN	TYPE	DESCRIPTION
CK, /CK	Input	Clock: CK and /CK are differential clock inputs. All address and control input signals are sampled on the crossing of the positive edge of CK and negative edge of /CK. Output (read) data is referenced to the crossings of CK and /CK (both directions of crossing).
CKE	Input	Clock Enable: CKE HIGH activates, and CKE LOW deactivates internal clock signals, and device input buffers and output drivers. Taking CKE LOW provides PRECHARGE POWER DOWN and SELF REFRESH operation (all banks idle), or ACTIVE POWER DOWN (row ACTIVE in any bank). CKE is synchronous for POWER DOWN entry and exit, and for SELF REFRESH entry. CKE is asynchronous for SELF REFRESH exit, and for output disable. CKE must be maintained high throughout READ and WRITE accesses. Input buffers, excluding CK, /CK and CKE are disabled during POWER DOWN. Input buffers, excluding CKE are disabled during SELF REFRESH. CKE is an SSTL_2 input, but will detect an LVCMOS LOW level after Vdd is applied.
/CS	Input	Chip Select : Enables or disables all inputs except CK, /CK, CKE, DQS and DM. All commands are masked when CS is registered high. CS provides for external bank selection on systems with multiple banks. CS is considered part of the command code.
BA0, BA1	Input	Bank Address Inputs: BA0 and BA1 define to which bank an ACTIVE, Read, Write or PRECHARGE command is being applied.
A0 ~ A10	Input	Address Inputs: Provide the row address for ACTIVE commands, and the column address and AUTO PRECHARGE bit for READ/WRITE commands, to select one location out of the memory array in the respective bank. A8 is sampled during a precharge command to determine whether the PRECHARGE applies to one bank (A8 LOW) or all banks (A8 HIGH). If only one bank is to be precharged, the bank is selected by BA0, BA1. The address inputs also provide the op code during a MODE REGISTER SET command. BA0 and BA1 define which mode register is loaded during the MODE REGISTER SET command (MRS or EMRS).
/RAS, /CAS, /WE	Input	Command Inputs: /RAS, /CAS and /WE (along with /CS) define the command being entered.
DM0 ~ DM3	Input	Input Data Mask: DM(0~3) is an input mask signal for write data. Input data is masked when DM is sampled HIGH along with that input data during a WRITE access. DM is sampled on both edges of DQS. Although DM pins are input only, the DM loading matches the DQ and DQS loading. DM0 corresponds to the data on DQ0-Q7; DM1 corresponds to the data on DQ8-Q15; DM2 corresponds to the data on DQ16-Q23; DM3 corresponds to the data on DQ24-Q31.
DQS	I/O	Data Strobe: Output with read data, input with write data. Edge aligned with read data, centered in write data. Used to capture write data.
DQ0 ~ DQ31	I/O	Data input / output pin : Data Bus
VDD/VSS	Supply	Power supply for internal circuits and input buffers.
VDDQ/VSSQ	Supply	Power supply for output buffers for noise immunity.
VREF	Supply	Reference voltage for inputs for SSTL interface.
NC	NC	No connection.

**FUNCTIONAL BLOCK DIAGRAM**

4Banks x 512Kbit x 32 I/O Double Data Rate Synchronous DRAM



**SIMPLIFIED COMMAND TRUTH TABLE**

Command	CKEn-1	CKEn	CS	RAS	CAS	WE	ADDR	A8/AP	BA	Note
Extended Mode Register Set	H	X	L	L	L	L	OP code			1,2
Mode Register Set	H	X	L	L	L	L	OP code			1,2
Device Deselect	H	X	H	X	X	X	X			1
No Operation			L	H	H	H				
Bank Active	H	X	L	L	H	H	RA		V	1
Read	H	X	L	H	L	H	CA	L	V	1
Read with Autoprecharge								H		1,3
Write	H	X	L	H	L	L	CA	L	V	1
Write with Autoprecharge								H		1,4
Precharge All Banks	H	X	L	L	H	L	X	H	X	1,5
Precharge selected Bank								L	V	1
Read Burst Stop	H	X	L	H	H	L	X			1
Auto Refresh	H	H	L	L	L	H	X			1
Self Refresh	Entry	H	L	L	L	L	H	X		1
	Exit	L	H	H	X	X	X			1
Precharge Power Down Mode	Entry			H	L	H	X	X	X	X
		L	H			H	H	1		
	Exit	L	H	H	X	X	X	1		
				L	H	H	H	1		
Active Power Down Mode	Entry	H	L	H	X	X	X	X		1
				L	V	V	V			1
	Exit	L	H	X						1

( H=Logic High Level, L=Logic Low Level, X=Don't Care, V=Valid Data Input, OP Code=Operand Code, NOP=No Operation )

**Note :**

- DM(0~3) states are Don't Care. Refer to below Write Mask Truth Table.
- OP Code(Operand Code) consists of A0~A10 and BA0~BA1 used for Mode Register setting during Extended MRS or MRS. Before entering Mode Register Set mode, all banks must be in a precharge state and MRS command can be issued after tRP period from Prechagre command.
- If a Read with Autoprecharge command is detected by memory component in CK(n), then there will be no command presented to activated bank until CK(n+BL/2+tRP).
- If a Write with Autoprecharge command is detected by memory component in CK(n), then there will be no command presented to activated bank until CK(n+BL/2+1+tDPL+tRP). Last Data-In to Prechagre delay(tDPL) which is also called Write Recovery Time (tWR) is needed to guarantee that the last data has been completely written.
- If A8/AP is High when Precharge command being issued, BA0/BA1 are ignored and all banks are selected to be precharged.

**WRITE MASK TRUTH TABLE**

Function	CKEn-1	CKEn	/CS, /RAS, /CAS, /WE	DM(0~3)	ADDR	A8/ AP	BA	Note
Data Write	H	X	X	L		X		1,2
Data-In Mask	H	X	X	H		X		1,2

**Note :**

1. Write Mask command masks burst write data with reference to DQS(Data Strobes) and it is not related with read data.
2. DM0 corresponds to the data on DQ0-Q7; DM1 corresponds to the data on DQ8-Q15; DM2 corresponds to the data on DQ16-Q23; DM3 corresponds to the data on DQ24-Q31.

**OPERATION COMMAND TRUTH TABLE - I**

Current State	/CS	/RAS	/CAS	/WE	Address	Command	Action
IDLE	H	X	X	X	X	DSEL	NOP or power down <sup>3</sup>
	L	H	H	H	X	NOP	NOP or power down <sup>3</sup>
	L	H	H	L	X	BST	ILLEGAL <sup>4</sup>
	L	H	L	H	BA, CA, AP	READ/READAP	ILLEGAL <sup>4</sup>
	L	H	L	L	BA, CA, AP	WRITE/WRITEAP	ILLEGAL <sup>4</sup>
	L	L	H	H	BA, RA	ACT	Row Activation
	L	L	H	L	BA, AP	PRE/PALL	NOP
	L	L	L	H	X	AREF/SREF	Auto Refresh or Self Refresh <sup>5</sup>
ROW ACTIVE	L	L	L	L	OPCODE	MRS	Mode Register Set
	H	X	X	X	X	DSEL	NOP
	L	H	H	H	X	NOP	NOP
	L	H	H	L	X	BST	ILLEGAL <sup>4</sup>
	L	H	L	H	BA, CA, AP	READ/READAP	Begin read : optional AP <sup>6</sup>
	L	H	L	L	BA, CA, AP	WRITE/WRITEAP	Begin write : optional AP <sup>6</sup>
	L	L	H	H	BA, RA	ACT	ILLEGAL <sup>4</sup>
	L	L	H	L	BA, AP	PRE/PALL	Precharge <sup>7</sup>
READ	L	L	L	H	X	AREF/SREF	ILLEGAL <sup>11</sup>
	L	L	L	L	OPCODE	MRS	ILLEGAL <sup>11</sup>
	H	X	X	X	X	DSEL	Continue burst to end
	L	H	H	H	X	NOP	Continue burst to end
	L	H	H	L	X	BST	Terminate burst
	L	H	L	H	BA, CA, AP	READ/READAP	Term burst, new read:optional AP <sup>8</sup>
	L	H	L	L	BA, CA, AP	WRITE/WRITEAP	ILLEGAL
	L	L	H	H	BA, RA	ACT	ILLEGAL <sup>4</sup>
WRITE	L	L	H	L	BA, AP	PRE/PALL	Term burst, precharge
	L	L	L	H	X	AREF/SREF	ILLEGAL <sup>11</sup>
	L	L	L	L	OPCODE	MRS	ILLEGAL <sup>11</sup>
	H	X	X	X	X	DSEL	Continue burst to end
	L	H	H	H	X	NOP	Continue burst to end
WRITE	L	H	H	L	X	BST	ILLEGAL <sup>4</sup>
	L	H	L	H	BA, CA, AP	READ/READAP	Term burst, new read:optional AP <sup>8</sup>
WRITE	L	H	L	L	BA, CA, AP	WRITE/WRITEAP	Term burst, new write:optional AP

**OPERATION COMMAND TRUTH TABLE - II**

Current State	/CS	/RAS	/CAS	/WE	Address	Command	Action
WRITE	L	L	H	H	BA, RA	ACT	ILLEGAL <sup>4</sup>
	L	L	H	L	BA, AP	PRE/PALL	Term burst, precharge
	L	L	L	H	X	AREF/SREF	ILLEGAL <sup>11</sup>
	L	L	L	L	OPCODE	MRS	ILLEGAL <sup>11</sup>
READ WITH AUTOPRE-CHARGE	H	X	X	X	X	DSEL	Continue burst to end
	L	H	H	H	X	NOP	Continue burst to end
	L	H	H	L	X	BST	ILLEGAL
	L	H	L	H	BA, CA, AP	READ/READAP	ILLEGAL <sup>10</sup>
	L	H	L	L	BA, CA, AP	WRITE/WRITEAP	ILLEGAL <sup>10</sup>
	L	L	H	H	BA, RA	ACT	ILLEGAL <sup>4,10</sup>
	L	L	H	L	BA, AP	PRE/PALL	ILLEGAL <sup>4,10</sup>
	L	L	L	H	X	AREF/SREF	ILLEGAL <sup>11</sup>
WRITE AUTOPRE-CHARGE	H	X	X	X	X	DSEL	Continue burst to end
	L	H	H	H	X	NOP	Continue burst to end
	L	H	H	L	X	BST	ILLEGAL
	L	H	L	H	BA, CA, AP	READ/READAP	ILLEGAL <sup>10</sup>
	L	H	L	L	BA, CA, AP	WRITE/WRITEAP	ILLEGAL <sup>10</sup>
	L	L	H	H	BA, RA	ACT	ILLEGAL <sup>4,10</sup>
	L	L	H	L	BA, AP	PRE/PALL	ILLEGAL <sup>4,10</sup>
	L	L	L	H	X	AREF/SREF	ILLEGAL <sup>11</sup>
PRE-CHARGE	H	X	X	X	X	DSEL	NOP-Enter IDLE after tRP
	L	H	H	H	X	NOP	NOP-Enter IDLE after tRP
	L	H	H	L	X	BST	ILLEGAL <sup>4</sup>
	L	H	L	H	BA, CA, AP	READ/READAP	ILLEGAL <sup>4,10</sup>
	L	H	L	L	BA, CA, AP	WRITE/WRITEAP	ILLEGAL <sup>4,10</sup>
	L	L	H	H	BA, RA	ACT	ILLEGAL <sup>4,10</sup>
	L	L	H	L	BA, AP	PRE/PALL	NOP-Enter IDLE after tRP
	L	L	L	H	X	AREF/SREF	ILLEGAL <sup>11</sup>
L	L	L	L	OPCODE	MRS	ILLEGAL <sup>11</sup>	

**OPERATION COMMAND TRUTH TABLE - III**

Current State	/CS	/RAS	/CAS	/WE	Address	Command	Action
ROW ACTIVATING	H	X	X	X	X	DSEL	NOP - Enter ROW ACT after tRCD
	L	H	H	H	X	NOP	NOP - Enter ROW ACT after tRCD
	L	H	H	L	X	BST	ILLEGAL <sup>4</sup>
	L	H	L	H	BA, CA, AP	READ/READAP	ILLEGAL <sup>4,10</sup>
	L	H	L	L	BA, CA, AP	WRITE/WRITEAP	ILLEGAL <sup>4,10</sup>
	L	L	H	H	BA, RA	ACT	ILLEGAL <sup>4,9,10</sup>
	L	L	H	L	BA, AP	PRE/PALL	ILLEGAL <sup>4,10</sup>
	L	L	L	H	X	AREF/SREF	ILLEGAL <sup>11</sup>
	L	L	L	L	OPCODE	MRS	ILLEGAL <sup>11</sup>
WRITE RECOVERING	H	X	X	X	X	DSEL	NOP - Enter ROW ACT after tWR
	L	H	H	H	X	NOP	NOP - Enter ROW ACT after tWR
	L	H	H	L	X	BST	ILLEGAL <sup>4</sup>
	L	H	L	H	BA, CA, AP	READ/READAP	ILLEGAL
	L	H	L	L	BA, CA, AP	WRITE/WRITEAP	ILLEGAL
	L	L	H	H	BA, RA	ACT	ILLEGAL <sup>4,10</sup>
	L	L	H	L	BA, AP	PRE/PALL	ILLEGAL <sup>4,11</sup>
	L	L	L	H	X	AREF/SREF	ILLEGAL <sup>11</sup>
	L	L	L	L	OPCODE	MRS	ILLEGAL <sup>11</sup>
WRITE RECOVERING WITH AUTOPRE-CHARGE	H	X	X	X	X	DSEL	NOP - Enter precharge after tDPL
	L	H	H	H	X	NOP	NOP - Enter precharge after tDPL
	L	H	H	L	X	BST	ILLEGAL <sup>4</sup>
	L	H	L	H	BA, CA, AP	READ/READAP	ILLEGAL <sup>4,8,10</sup>
	L	H	L	L	BA, CA, AP	WRITE/WRITEAP	ILLEGAL <sup>4,10</sup>
	L	L	H	H	BA, RA	ACT	ILLEGAL <sup>4,10</sup>
	L	L	H	L	BA, AP	PRE/PALL	ILLEGAL <sup>4,11</sup>
	L	L	L	H	X	AREF/SREF	ILLEGAL <sup>11</sup>
	L	L	L	L	OPCODE	MRS	ILLEGAL <sup>11</sup>
REFRESHING	H	X	X	X	X	DSEL	NOP - Enter IDLE after tRC
	L	H	H	H	X	NOP	NOP - Enter IDLE after tRC
	L	H	H	L	X	BST	ILLEGAL <sup>11</sup>
	L	H	L	H	BA, CA, AP	READ/READAP	ILLEGAL <sup>11</sup>

**OPERATION COMMAND TRUTH TABLE - IV**

Current State	/CS	/RAS	/CAS	/WE	Address	Command	Action
WRITE	L	H	L	L	BA, CA, AP	WRITE/WRITEAP	ILLEGAL <sup>11</sup>
	L	L	H	H	BA, RA	ACT	ILLEGAL <sup>11</sup>
	L	L	H	L	BA, AP	PRE/PALL	ILLEGAL <sup>11</sup>
	L	L	L	H	X	AREF/SREF	ILLEGAL <sup>11</sup>
	L	L	L	L	OPCODE	MRS	ILLEGAL <sup>11</sup>
MODE REGISTER ACCESSING	H	X	X	X	X	DSEL	NOP - Enter IDLE after tMRD
	L	H	H	H	X	NOP	NOP - Enter IDLE after tMRD
	L	H	H	L	X	BST	ILLEGAL <sup>11</sup>
	L	H	L	H	BA, CA, AP	READ/READAP	ILLEGAL <sup>11</sup>
	L	H	L	L	BA, CA, AP	WRITE/WRITEAP	ILLEGAL <sup>11</sup>
	L	L	H	H	BA, RA	ACT	ILLEGAL <sup>11</sup>
	L	L	H	L	BA, AP	PRE/PALL	ILLEGAL <sup>11</sup>
	L	L	L	H	X	AREF/SREF	ILLEGAL <sup>11</sup>
L	L	L	L	OPCODE	MRS	ILLEGAL <sup>11</sup>	

**Note :**

1. H - Logic High Level, L - Logic Low Level, X - Don't Care, V - Valid Data Input, BA - Bank Address, AP - AutoPrecharge Address, CA - Column Address, RA - Row Address, NOP - NO Operation.
2. All entries assume that CKE was active(high level) during the preceding clock cycle.
3. If both banks are idle and CKE is inactive(low level), then in power down mode.
4. Illegal to bank in specified state. Function may be legal in the bank indicated by Bank Address(BA) depending on the state of that bank.
5. If both banks are idle and CKE is inactive(low level), then self refresh mode.
6. Illegal if tRCD is not met.
7. Illegal if tRAS is not met.
8. Must satisfy bus contention, bus turn around, and/or write recovery requirements.
9. Illegal if tRRD is not met.
10. Illegal for single bank, but legal for other banks in multi-bank devices.
11. Illegal for all banks.

**CKE FUNCTION TRUTH TABLE**

Current State	CKEn-1	CKEn	/CS	/RAS	/CAS	/WE	/ADD	Action
SELF REFRESH <sup>1</sup>	H	X	X	X	X	X	X	INVALID
	L	H	H	X	X	X	X	Exit self refresh, enter idle after tSREX
	L	H	L	H	H	H	X	Exit self refresh, enter idle after tSREX
	L	H	L	H	H	L	X	ILLEGAL
	L	H	L	H	L	X	X	ILLEGAL
	L	H	L	L	X	X	X	ILLEGAL
	L	L	X	X	X	X	X	NOP, continue self refresh
POWER DOWN <sup>2</sup>	H	X	X	X	X	X	X	INVALID
	L	H	H	X	X	X	X	Exit power down, enter idle
	L	H	L	H	H	H	X	Exit power down, enter idle
	L	H	L	H	H	L	X	ILLEGAL
	L	H	L	H	L	X	X	ILLEGAL
	L	H	L	L	X	X	X	ILLEGAL
	L	L	X	X	X	X	X	NOP, continue power down mode
ALL BANKS IDLE <sup>4</sup>	H	H	X	X	X	X	X	See operation command truth table
	H	L	L	L	L	H	X	Enter self refresh
	H	L	H	X	X	X	X	Exit power down
	H	L	L	H	H	H	X	Exit power down
	H	L	L	H	H	L	X	ILLEGAL
	H	L	L	H	L	X	X	ILLEGAL
	H	L	L	L	H	X	X	ILLEGAL
	H	L	L	L	L	L	X	ILLEGAL
	L	L	X	X	X	X	X	NOP
ANY STATE OTHER THAN ABOVE	H	H	X	X	X	X	X	See operation command truth table
	H	L	X	X	X	X	X	ILLEGAL <sup>5</sup>
	L	H	X	X	X	X	X	INVALID
	L	L	X	X	X	X	X	INVALID

**Note :**

When CKE=L, all DQ and DQS must be in Hi-Z state.

1. CKE and /CS must be kept high for a minimum of 200 stable input clocks before issuing any command.
2. All command can be stored after 2 clocks from low to high transition of CKE.
3. Illegal if CK is suspended or stopped during the power down mode.
4. Self refresh can be entered only from the all banks idle state.
5. Disabling CK may cause malfunction of any bank which is in active state.



## POWER-UP SEQUENCE AND DEVICE INITIALIZATION

DDR SDRAMs must be powered up and initialized in a predefined manner. Operational procedures other than those specified may result in undefined operation. Power must first be applied to VDD, then to VDDQ, and finally to VREF (and to the system VTT). VTT must be applied after VDDQ to avoid device latch-up, which may cause permanent damage to the device. VREF can be applied anytime after VDDQ, but is expected to be nominally coincident with VTT. Except for CKE, inputs are not recognized as valid until after VREF is applied. CKE is an SSTL\_2 input, but will detect an LVCMOS LOW level after VDD is applied. Maintaining an LVCMOS LOW level on CKE during power-up is required to guarantee that the DQ and DQS outputs will be in the High-Z state, where they will remain until driven in normal operation (by a read access). After all power supply and reference voltages are stable, and the clock is stable, the DDR SDRAM requires a 200us delay prior to applying an executable command.

Once the 200us delay has been satisfied, a DESELECT or NOP command should be applied, and CKE should be brought HIGH. Following the NOP command, a PRECHARGE ALL command should be applied. Next a EXTENDED MODE REGISTER SET command should be issued for the Extended Mode Register, to enable the DLL, then a MODE REGISTER SET command should be issued for the Mode Register, to reset the DLL, and to program the operating parameters. 200 clock cycles are required between the DLL reset and any command. During the 200 cycles of CK, for DLL locking, executable commands are disallowed (a DESELECT or NOP command must be applied). After the 200 clock cycles, a PRECHARGE ALL command should be applied, placing the device in the all banks idle state.

Once in the idle state, two AUTO REFRESH cycles must be performed. Additionally, a MODE REGISTER SET command for the Mode Register with the reset DLL bit deactivated (i.e. to program operating parameters without resetting the DLL) must be performed. Following these cycles, the DDR SDRAM is ready for normal operation.

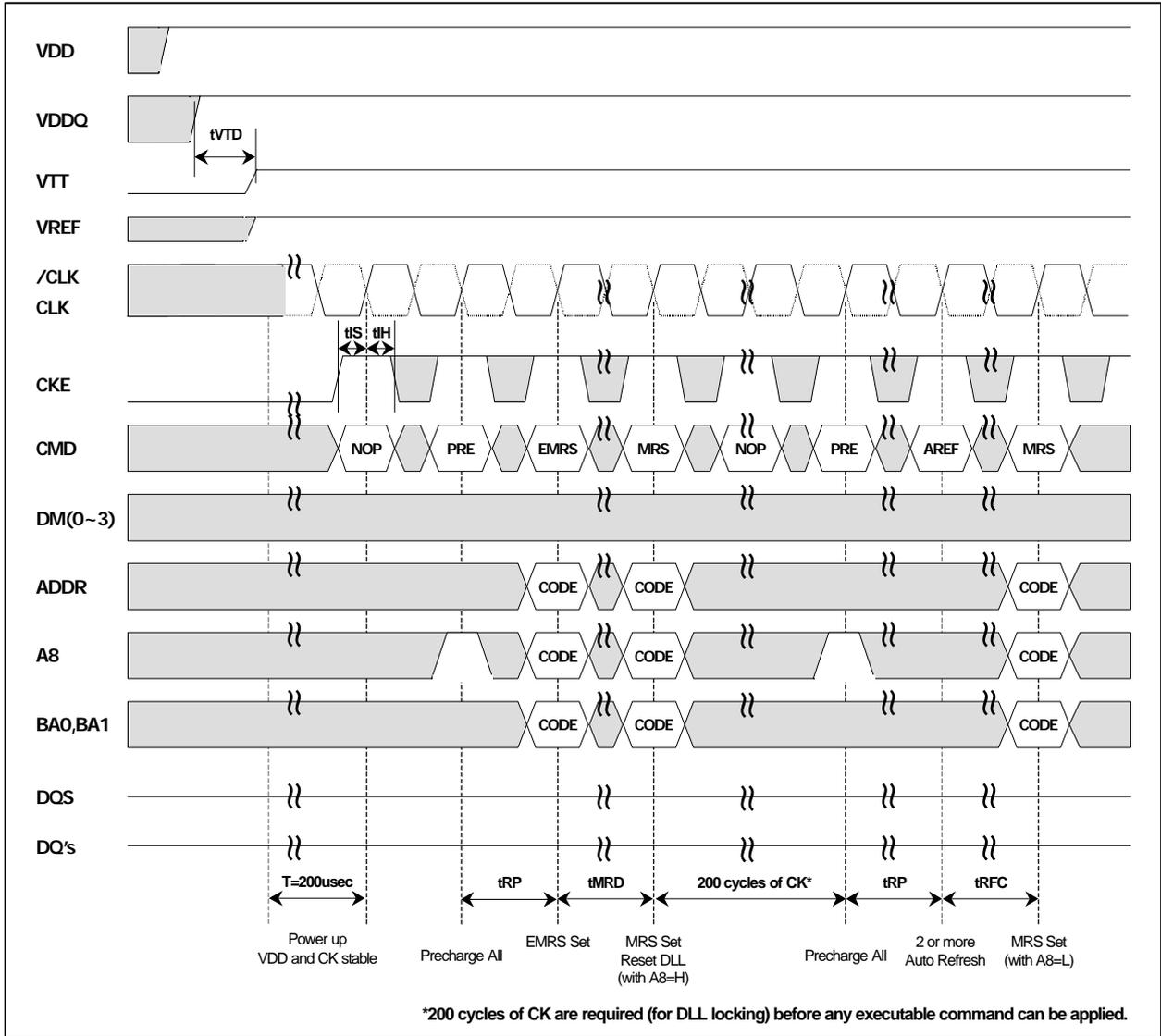
1. Apply power - VDD, VDDQ, VTT, VREF in the following power up sequencing and attempt to maintain CKE at LVCMOS low state. (All the other input pins may be undefined.)
  - VDD and VDDQ are driven from a single power converter output.
  - VTT is limited to  $1.44V$  (reflecting  $VDDQ(max)/2 + 50mV$  VREF variation +  $40mV$  VTT variation).
  - VREF tracks  $VDDQ/2$ .
  - A minimum resistance of 42 Ohms (22 ohm series resistor + 22 ohm parallel resistor - 5% tolerance) limits the input current from the VTT supply into any pin.
  - If the above criteria cannot be met by the system design, then the following sequencing and voltage relationship must be adhered to during power up.

Voltage description	Sequencing	Voltage relationship to avoid latch-up
VDDQ	After or with VDD	$< VDD + 0.3V$
VTT	After or with VDDQ	$< VDDQ + 0.3V$
VREF	After or with VDDQ	$< VDDQ + 0.3V$

2. Start clock and maintain stable clock for a minimum of 200usec.
3. After stable power and clock, apply NOP condition and take CKE high.
4. Issue Extended Mode Register Set (EMRS) to enable DLL.
5. Issue Mode Register Set (MRS) to reset DLL and set device to idle state with bit A8=High. (An additional 200 cycles of clock are required for locking DLL)
6. Issue Precharge commands for all banks of the device.

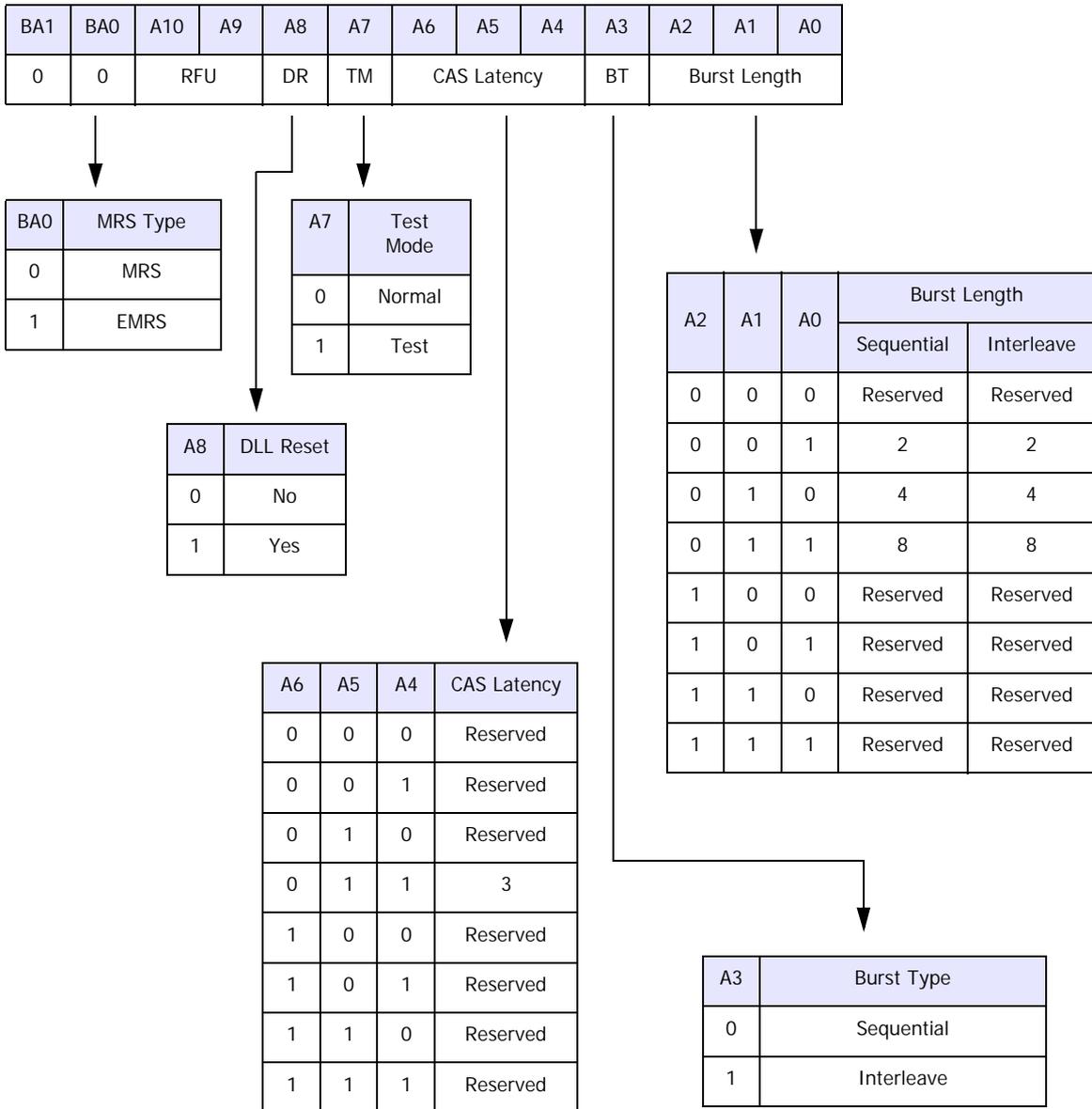
7. Issue 2 or more Auto Refresh commands.
8. Issue a Mode Register Set command to initialize the mode register with bit A8 = Low.

**Power-Up Sequence**



## MODE REGISTER SET (MRS)

The mode register is used to store the various operating modes such as /CAS latency, addressing mode, burst length, burst type, test mode, DLL reset. The mode register is program via MRS command. This command is issued by the low signals of /RAS, /CAS, /CS, /WE and BA0. This command can be issued only when all banks are in idle state and CKE must be high at least one cycle before the Mode Register Set Command can be issued. Two cycles are required to write the data in mode register. During the the MRS cycle, any command cannot be issued. Once mode register field is determined, the information will be held until resetted by another MRS command.



**BURST DEFINITION**

Burst Length	Starting Address (A2,A1,A0)	Sequential	Interleave
2	XX0	0, 1	0, 1
	XX1	1, 0	1, 0
4	X00	0, 1, 2, 3	0, 1, 2, 3
	X01	1, 2, 3, 0	1, 0, 3, 2
	X10	2, 3, 0, 1	2, 3, 0, 1
	X11	3, 0, 1, 2	3, 2, 1, 0
8	000	0, 1, 2, 3, 4, 5, 6, 7	0, 1, 2, 3, 4, 5, 6, 7
	001	1, 2, 3, 4, 5, 6, 7, 0	1, 0, 3, 2, 5, 4, 7, 6
	010	2, 3, 4, 5, 6, 7, 0, 1	2, 3, 0, 1, 6, 7, 4, 5
	011	3, 4, 5, 6, 7, 0, 1, 2	3, 2, 1, 0, 7, 6, 5, 4
	100	4, 5, 6, 7, 0, 1, 2, 3	4, 5, 6, 7, 0, 1, 2, 3
	101	5, 6, 7, 0, 1, 2, 3, 4	5, 4, 7, 6, 1, 0, 3, 2
	110	6, 7, 0, 1, 2, 3, 4, 5	6, 7, 4, 5, 2, 3, 0, 1
	111	0, 1, 2, 3, 4, 5, 6, 7	7, 6, 5, 4, 3, 2, 1, 0

**BURST LENGTH & TYPE**

Read and write accesses to the DDR SDRAM are burst oriented, with the burst length being programmable. The burst length determines the maximum number of column locations that can be accessed for a given Read or Write command. Burst lengths of 2, 4 or 8 locations are available for both the sequential and the interleaved burst types. Reserved states should not be used, as unknown operation or incompatibility with future versions may result.

When a Read or Write command is issued, a block of columns equal to the burst length is effectively selected. All accesses for that burst take place within this block, meaning that the burst wraps within the block if a boundary is reached. The block is uniquely selected by A1-Ai when the burst length is set to two, by A2-Ai when the burst length is set to four and by A3-Ai when the burst length is set to eight (where Ai is the most significant column address bit for a given configuration). The remaining (least significant) address bit(s) is (are) used to select the starting location within the block. The programmed burst length applies to both Read and Write bursts.

Accesses within a given burst may be programmed to be either sequential or interleaved; this is referred to as the burst type and is selected via bit A3. The ordering of accesses within a burst is determined by the burst length, the burst type and the starting column address, as shown in Burst Definitionon Table

## CAS LATENCY

The Read latency or CAS latency is the delay in clock cycles between the registration of a Read command and the availability of the first burst of output data. The latency can be programmed 3 or 4 clocks.

If a Read command is registered at clock edge  $n$ , and the latency is  $m$  clocks, the data is available nominally coincident with clock edge  $n + m$ .

Reserved states should not be used as unknown operation or incompatibility with future versions may result.

## DLL RESET

The DLL must be enabled for normal operation. DLL enable is required during power up initialization, and upon returning to normal operation after having disabled the DLL for the purpose of debug or evaluation. The DLL is automatically disabled when entering self refresh operation and is automatically re-enabled upon exit of self refresh operation. Any time the DLL is enabled, 200 clock cycles must occur to allow time for the internal clock to lock to the externally applied clock before an any command can be issued.

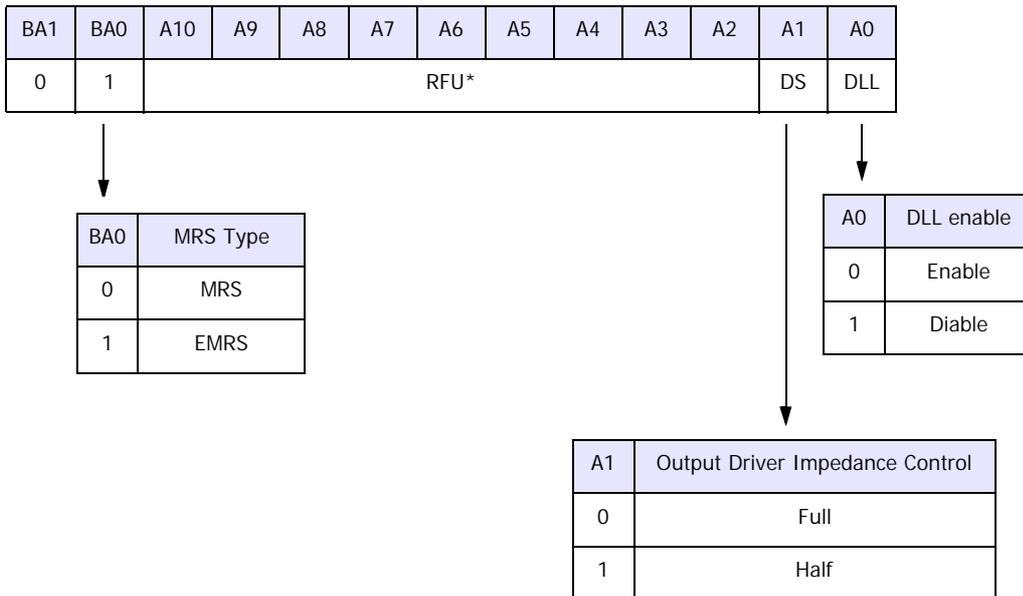
## OUTPUT DRIVER IMPEDANCE CONTROL

The Full drive strength for all outputs is specified to be SSTL\_2, Class II. Hynix also supports a Half strength driver option, intended for lighter load and/or point-to-point environments. Selection of the Half strength driver option will reduce the output drive strength by about 50% of that of the Full strength driver.

## EXTENDED MODE REGISTER SET (EMRS)

The Extended Mode Register controls functions beyond those controlled by the Mode Register; these additional functions include DLL enable/disable, output driver strength selection(optional). These functions are controlled via the bits shown below. The Extended Mode Register is programmed via the Mode Register Set command ( BA0=1 and BA1=0) and will retain the stored information until it is programmed again or the device loses power.

The Extended Mode Register must be loaded when all banks are idle and no bursts are in progress, and the controller must wait the specified time before initiating any subsequent operation. Violating either of these requirements will result in unspecified operation.



\* All bits in RFU address fields must be programmed to Zero, all other states are reserved for future usage.

**ABSOLUTE MAXIMUM RATINGS**

Parameter	Symbol	Rating	Unit
Ambient Temperature	TA	0 ~ 70	°C
Storage Temperature	TSTG	-55 ~ 125	°C
Voltage on Any Pin relative to VSS	VIN, VOUT	-0.5 ~ 3.6	V
Voltage on VDD relative to VSS	VDD	-0.5 ~ 3.6	V
Voltage on VDDQ relative to VSS	VDDQ	-0.5 ~ 3.6	V
Output Short Circuit Current	IOS	50	mA
Power Dissipation	PD	1	W
Soldering Temperature · Time	TSOLDER	260 · 10	°C · sec

**Note :** Operation at above absolute maximum rating can adversely affect device reliability

**DC OPERATING CONDITIONS** (TA=0 to 70°C, Voltage referenced to VSS = 0V)

Parameter	Symbol	Min	Typ.	Max	Unit	Note
Power Supply Voltage	VDD	2.375	2.5	2.625	V	
Power Supply Voltage	VDDQ	2.375	2.5	2.625	V	1
Input High Voltage	VIH	VREF + 0.15	-	VDDQ + 0.3	V	
Input Low Voltage	VIL	-0.3	-	VREF - 0.15	V	2
Termination Voltage	VTT	VREF - 0.04	VREF	VREF + 0.04	V	
Reference Voltage	VREF	0.49*VDDQ	0.5*VDDQ	0.51*VDDQ	V	3

**Note :**

- VDDQ must not exceed the level of VDD.
- VIL (min) is acceptable -1.5V AC pulse width with  $\leq 5$ ns of duration.
- VREF is expected to be equal to  $0.5 \cdot VDDQ$  of the transmitting device, and to track variations in the dc level of the same.  
Peak to peak noise on VREF may not exceed  $\pm 2\%$  of the dc value.

**DC CHARACTERISTICS I** (TA=0 to 70°C, Voltage referenced to VSS = 0V)

Parameter	Symbol	Min.	Max	Unit	Note
Input Leakage Current	ILI	-5	5	uA	1
Output Leakage Current	ILO	-5	5	uA	2
Output High Voltage	VOH	VTT + 0.76	-	V	IOH = -15.2mA
Output Low Voltage	VOL	-	VTT - 0.76	V	IOL = +15.2mA

**Note :** 1. VIN = 0 to 3.6V, All other pins are not tested under VIN = 0V. 2. DOUT is disabled, VOUT = 0 to 2.7V

**DC CHARACTERISTICS II** (TA=0 to 70°C, Voltage referenced to VSS = 0V)

Parameter	Symbol	Test Condition	Speed			Unit	Note
			7M	75	8		
Operating Current	IDD1	Burst length=2, One bank active tRC ≥ tRC(min), IOL=0mA	220	210	210	mA	1
Precharge Standby Current in Power Down Mode	IDD2P	CKE ≤ VIL(max), tCK = min	10			mA	
Precharge Standby Current in Non Power Down Mode	IDD2N	CKE ≥ VIH(min), /CS ≥ VIH(min), tCK = min, Input signals are changed one time during 2clks	50			mA	
Active Standby Current in Power Down Mode	IDD3P	CKE ≤ VIL(max), tCK = min	10			mA	
Active Standby Current in Non Power Down Mode	IDD3N	CKE ≥ VIH(min), /CS ≥ VIH(min), tCK = min, Input signals are changed one time during 2clks	55			mA	
Burst Mode Operating Current	IDD4	tCK ≥ tCK(min), IOL= 0mA All banks active	320	310	300	mA	1
Auto Refresh Current	IDD5	tRC ≥ tRFC(min), All banks active	280			mA	1,2
Self Refresh Current	IDD6	CKE ≤ 0.2V	3			mA	

**Note :**

1. IDD1, IDD4 and IDD5 depend on output loading and cycle rates. Specified values are measured with the output open.
2. Min. of tRFC (Auto Refresh Row Cycle Time) is shown at AC CHARACTERISTICS.

**AC OPERATING CONDITIONS** (TA=0 to 70°C, Voltage referenced to VSS = 0V)

Parameter	Symbol	Min	Max	Unit	Note
Input High (Logic 1) Voltage, DQ, DQS and DM signals	VIH(AC)	VREF + 0.35		V	
Input Low (Logic 0) Voltage, DQ, DQS and DM signals	VIL(AC)		VREF - 0.35	V	
Input Differential Voltage, CK and /CK inputs	VID(AC)	0.7	VDDQ + 0.6	V	1
Input Crossing Point Voltage, CK and /CK inputs	VIX(AC)	0.5*VDDQ-0.2	0.5*VDDQ+0.2	V	2

**Note :**

1. VID is the magnitude of the difference between the input level on CK and the input on /CK.
2. The value of VIX is expected to equal 0.5\*VDDQ of the transmitting device and must track variations in the DC level of the same.

**AC OPERATING TEST CONDITIONS** (TA=0 to 70°C, Voltage referenced to VSS = 0V)

Parameter	Value	Unit
Reference Voltage	VDDQ x 0.5	V
Termination Voltage	VDDQ x 0.5	V
AC Input High Level Voltage (VIH, min)	VREF + 0.35	V
AC Input Low Level Voltage (VIL, max)	VREF - 0.35	V
Input Timing Measurement Reference Level Voltage	VREF	V
Output Timing Measurement Reference Level Voltage	VTT	V
Input Signal maximum peak swing	1.5	V
Input minimum Signal Slew Rate	1	V/ns
Termination Resistor (RT)	50	Ω
Series Resistor (RS)	25	Ω
Output Load Capacitance for Access Time Measurement (CL)	30	pF

**AC CHARACTERISTICS** (AC operating conditions unless otherwise noted)

Parameter	Symbol	7M		75		8		Unit	Note
		Min	Max	Min	Max	Min	Max		
Row Cycle Time	tRC	70	-	71.5	-	73	-	ns	
Auto Refresh Row Cycle Time	tRFC	77	-	77	-	77	-	ns	
Row Active Time	tRAS	49	120K	49	120K	49	120K	ns	
Row Address to Column Address Delay	tRCD	3	-	3	-	3	-	CK	
Row Active to Row Active Delay	tRRD	2	-	2	-	2	-	CK	
Column Address to Column Address Delay	tCCD	1	-	1	-	1	-	CK	
Row Precharge Time	tRP	3	-	3	-	3	-	CK	
Last Data-In to Precharge Delay Time (Write Recovery Time : tWR)	tDPL	2	-	2	-	2	-	CK	
Last Data-In to Read Command	tDRL	1	-	1	-	1	-	CK	
Auto Precharge Write Recovery + Precharge Time	tDAL	5	-	5	-	5	-	CK	
System Clock Cycle Time	CL = 3 tCK	7	10	7.5	10	8	10	ns	
Clock High Level Width	tCH	0.45	0.55	0.45	0.55	0.45	0.55	CK	
Clock Low Level Width	tCL	0.45	0.55	0.45	0.55	0.45	0.55	CK	
Data-Out edge to Clock edge Skew	tAC	-0.75	1.1	-0.75	1.1	-0.75	1.1	ns	
DQS-Out edge to Clock edge Skew	tDQSCK	-0.75	1.1	-0.75	1.1	-0.75	1.1	ns	
DQS-Out edge to Data-Out edge Skew	tDQSQ	-	0.5	-	0.5	-	0.5	ns	
Data-Out hold time from DQS	tQH	tHPmin -tQHS	-	tHPmin -tQHS	-	tHPmin -tQHS	-	ns	1,6
Clock Half Period	tHP	tCH/L min	-	tCH/L min	-	tCH/L min	-	ns	1,5
Data Hold Skew Factor	tQHS	-	0.75	-	0.75	-	0.75	ns	6
Input Setup Time	tIS	1.1	-	1.1	-	1.1	-	ns	2
Input Hold Time	tIH	1.1	-	1.1	-	1.1	-	ns	2
Write DQS High Level Width	tDQSH	0.4	0.6	0.4	0.6	0.4	0.6	CK	
Write DQS Low Level Width	tDQSL	0.4	0.6	0.4	0.6	0.4	0.6	CK	
Clock to First Rising edge of DQS-In	tDQSS	0.75	1.25	0.75	1.25	0.75	1.25	CK	
Data-In Setup Time to DQS-In (DQ & DM)	tDS	0.5	-	0.5	-	0.5	-	ns	3
Data-In Hold Time to DQS-In (DQ & DM)	tDH	0.5	-	0.5	-	0.5	-	ns	3

Parameter	Symbol	7M		75		8		Unit	Note
		Min	Max	Min	Max	Min	Max		
Read DQS Preamble Time	tRPRE	0.9	1.1	0.9	1.1	0.9	1.1	CK	
Read DQS Postamble Time	tRPST	0.4	0.6	0.4	0.6	0.4	0.6	CK	
Write DQS Preamble Setup Time	tWPRES	0	-	0	-	0	-	ns	
Write DQS Preamble Hold Time	tWPREH	0.25	-	0.25	-	0.25	-	CK	
Write DQS Postamble Time	tWPST	0.4	0.6	0.4	0.6	0.4	0.6	CK	
Mode Register Set Delay	tMRD	2	-	2	-	2	-	CK	
Exit Self Refresh to Any Execute Command	tXSC	200	-	200	-	200	-	CK	4

**Note :**

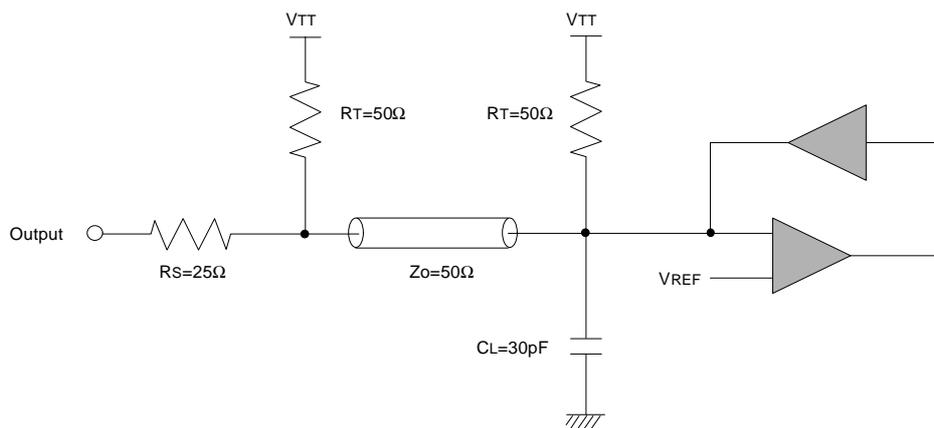
1. This calculation accounts for tDQSQ(max), the pulse width distortion of on-chip circuit and jitter.
2. Data sampled at the rising edges of the clock : A0~A10, BA0~BA1, CKE, /CS, /RAS, /CAS, /WE.
3. Data latched at both rising and falling edges of Data Strobes(DQS) : DQ, DM(0~3).
4. Minimum of 200 cycles of stable input clocks after Self Refresh Exit command, where CKE is held high, is required to complete Self Refresh Exit and lock the internal DLL circuit of DDR SDRAM.
5. Min (tCL, tCH) refers to the smaller of the actual clock low time and the actual clock high time as provided to the device (i.e. this value can be greater than the minimum specification limits for tCL and tCH).
6. tHP = minimum half clock period for any given cycle and is defined by clock high or clock low (tCH, tCL). tQHS consists of tDQSQmax, the pulse width distortion of on-chip clock circuits, data pin to pin skew and output pattern effects, and p-channel to n-channel variation of the output drivers.
7. DQS, DM and DQ input slew rate is specified to prevent double clocking of data and preserve setup and hold times. Signal transitions through the DC region must be monotonic.

**CAPACITANCE** ( $T_A=25^{\circ}\text{C}$ ,  $f=1\text{MHz}$ )

Parameter	Pin	Symbol	Min	Max	Unit
Input Clock Capacitance	CK, /CK	CCK	2.0	3.0	pF
Input Capacitance	All other input-only pins	CIN	2.0	3.0	pF
Input / Output Capacitance	DQ, DQS, DM	CIO	4.0	5.0	pF

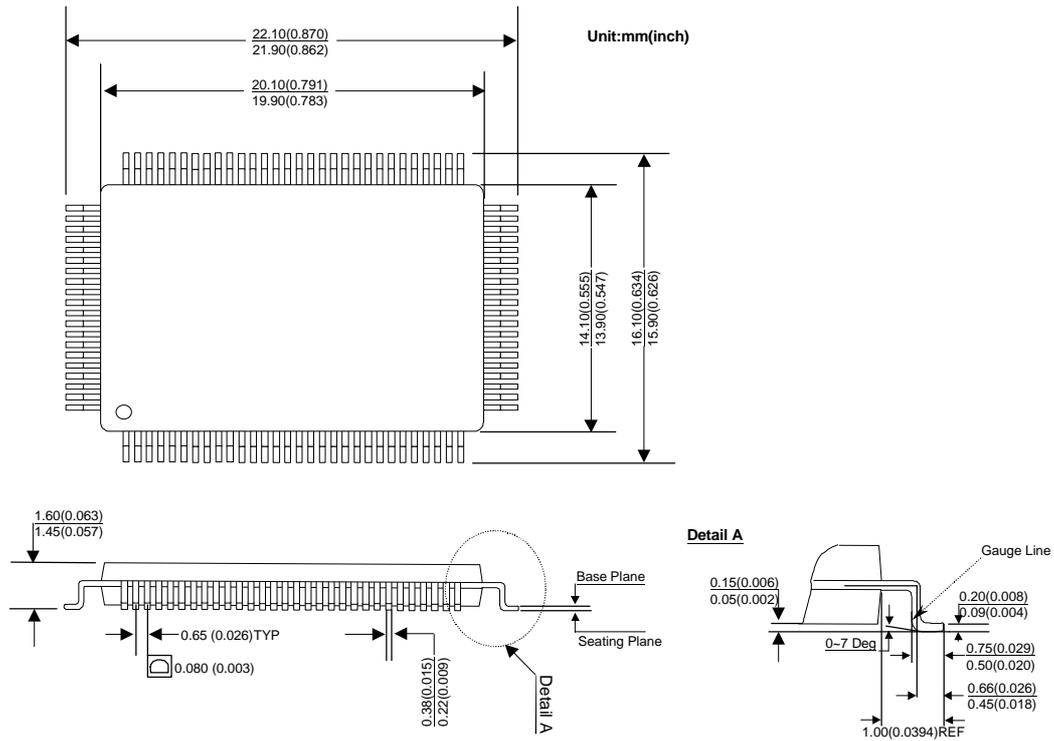
**Note :**

1.  $V_{DD}/V_{DDQ} = \text{min. to max.}$ ,  $V_{ODC} = V_{DDQ}/2$ ,  $V_{O\text{peak-to-peak}} = 0.2\text{V}$
2. Pins not under test are tied to GND.
3. These values are guaranteed by design and are tested on a sample basis only.

**OUTPUT LOAD CIRCUIT**


## PACKAGE INFORMATION

20mm x 14mm 100pin Low Quad Flat Package



All dimension in mm (inches). Notation is  $\frac{\text{MAX}}{\text{MIN}}$  or typical.